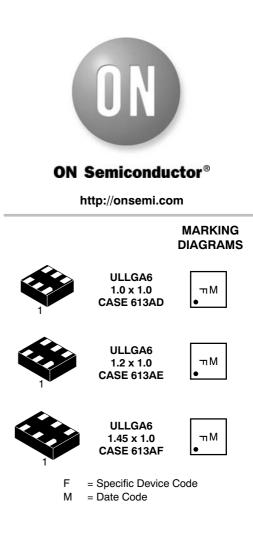
# **Configurable Multifunction Gate**

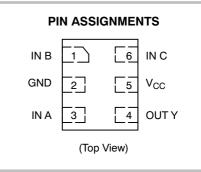
The NLX1G97 MiniGate  $^{\text{m}}$  is an advanced high-speed CMOS multifunction gate. The device allows the user to choose logic functions MUX, AND, OR, NAND, NOR, INVERT and BUFFER. The device has Schmitt-trigger inputs, thereby enhancing noise immunity.

The NLX1G97 input and output structures provide protection when voltages up to 7.0 V are applied, regardless of the supply voltage.

## Features

- High Speed:  $t_{PD} = 3.3 \text{ ns} (Typ) @ V_{CC} = 5.0 \text{ V}$
- Low Power Dissipation:  $I_{CC} = 1 \ \mu A$  (Maximum) at  $T_A = 25^{\circ}C$
- Power Down Protection Provided on inputs
- Balanced Propagation Delays
- Overvoltage Tolerant (OVT) Input and Output Pins
- Ultra-Small Packages
- These are Pb-Free Devices





## **ORDERING INFORMATION**

See detailed ordering and shipping information in the package dimensions section on page 7 of this data sheet.

1

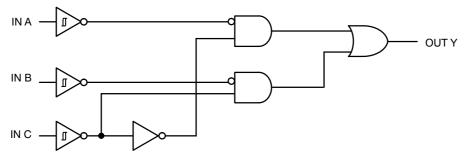


Figure 1. Function Diagram

## **PIN ASSIGNMENT**

1	IN B
2	GND
3	IN A
4	OUT Y
5	V <sub>CC</sub>
6	IN C

## FUNCTION TABLE\*

	Input		
А	В	С	Y
L	L	L	L
L	L	Н	L
L	Н	L	Н
L	Н	Н	L
Н	L	L	L
Н	L	Н	Н
Н	Н	L	Н
Н	Н	Н	Н

\*To select a logic function, please refer to "Logic Configurations section".

# LOGIC CONFIGURATIONS

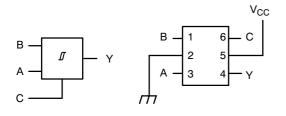


Figure 2. 2–Input MUX

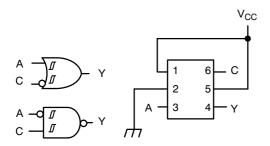


Figure 4. 2–Input OR with Input C Inverted (When B = "H")

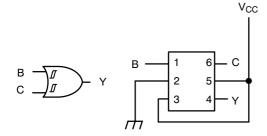


Figure 6. 2-Input OR (When A ="H")

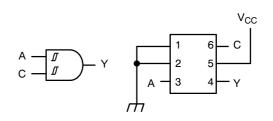


Figure 3. 2-Input AND (When B = "L")

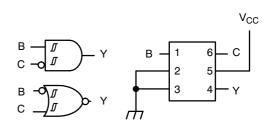


Figure 5. 2–Input AND with Input C Inverted (When A = "L")

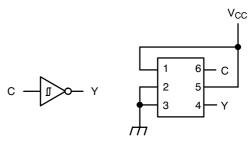


Figure 7. Inverter (When A = "L" and B = "H")

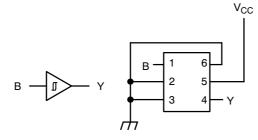


Figure 8. Buffer (When A = C = "L")

# MAXIMUM RATINGS

Symbol	Parameter		Value	Unit
V <sub>CC</sub>	DC Supply Voltage		-0.5 to +7.0	V
V <sub>IN</sub>	DC Input Voltage		-0.5 to +7.0	V
V <sub>OUT</sub>	DC Output Voltage		-0.5 to +7.0	V
I <sub>IK</sub>	DC Input Diode Current	V <sub>IN</sub> < GND	-50	mA
I <sub>OK</sub>	DC Output Diode Current	V <sub>OUT</sub> < GND	-50	mA
Ι <sub>Ο</sub>	DC Output Source/Sink Current		±50	mA
I <sub>CC</sub>	DC Supply Current Per Supply Pin		±100	mA
I <sub>GND</sub>	DC Ground Current per Ground Pin		±100	mA
T <sub>STG</sub>	Storage Temperature Range		-65 to +150	°C
ΤL	Lead Temperature, 1 mm from Case for 10 Sec	conds	260	°C
TJ	Junction Temperature Under Bias		150	°C
MSL	Moisture Sensitivity		Level 1	
F <sub>R</sub>	Flammability Rating Oxygen	Index: 28 to 34	UL 94 V-0 @ 0.125 in	
V <sub>ESD</sub>	Ŭ	nan Body Model (Note 2) Machine Model (Note 3) d Device Model (Note 4)	>2000 >200 N/A	V
ILATCHUP	Latchup Performance Above $V_{\mbox{CC}}$ and Below G	ND at 125°C (Note 5)	±500	mA

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability. 1. Measured with minimum pad spacing on an FR4 board, using 10 mm-by-1 inch, 2 ounce copper trace no air flow.

Tested to EIA/JESD22-A114-A.
 Tested to EIA/JESD22-A115-A.

4. Tested to JESD22-C101-A.

5. Tested to EIA/JESD78.

#### **RECOMMENDED OPERATING CONDITIONS**

Symbol	Parameter	Min	Max	Unit	
V <sub>CC</sub>	Positive DC Supply Voltage		1.65	5.5	V
V <sub>IN</sub>	Digital Input Voltage		0	5.5	V
V <sub>OUT</sub>	Output Voltage		0	5.5	V
T <sub>A</sub>	Operating Free-Air Temperature		-55	+125	°C
$\Delta t/\Delta V$	Input Transition Rise or Fall Rate	$V_{CC} = 2.5 V \pm 0.2 V V_{CC} = 3.3 V \pm 0.3 V V_{CC} = 5.0 V \pm 0.5 V$	0 0 0	No Limit No Llmit No Limit	nS/V

## DC ELECTRICAL CHARACTERISTICS

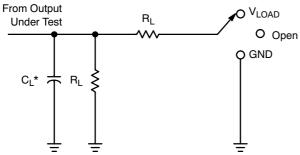
			v <sub>cc</sub>	-	Γ <sub>A</sub> = 25°	c	T <sub>A</sub> ≤	+85°C		55°C to 25°C	
Symbol	Parameter	Conditions	(V)	Min	Тур	Max	Min	Мах	Min	Max	Unit
$V_{T+}$	Positive		1.65	0.79		1.16		1.16		1.16	V
	Threshold Voltage		2.3	1.11		1.56		1.56		1.56	1
			3.0	1.5		1.87		1.87		1.87	1
			4.5	2.16		2.74		2.74		2.74	1
			5.5	2.61		3.33		3.33		3.33	1
V <sub>T-</sub>	Negative		1.65	0.35		0.62	0.35		0.35		V
	Threshold Voltage		2.3	0.58		0.87	0.58		0.58		1
	voltage		3.0	0.84		1.19	0.84		0.84		1
			4.5	1.41		1.9	1.41		1.41		1
			5.5	1.78		2.29	1.78		1.78		1
V <sub>H</sub>	Hysteresis		1.65	0.30		0.62	0.30	0.62	0.30	0.62	V
	Voltage		2.3	0.40		0.8	0.40	0.8	0.40	0.8	1
			3.0	0.53		0.87	0.53	0.87	0.53	0.87	1
			4.5	0.71		1.04	0.71	1.04	0.71	1.04	
			5.5	0.8		1.2	0.8	1.2	0.8	1.2	
V <sub>OH</sub>	Minimum High-Level	$V_{IN} = V_{T-MIN} \text{ or } V_{T+MAX}$ $I_{OH} = -50 \ \mu A$	1.65 - 5.5	V <sub>CC</sub> - 0.1			V <sub>CC</sub> - 0.1		V <sub>CC</sub> - 0.1		V
	Output Voltage	$V_{IN} = V_{T-MIN} \text{ or } V_{T+MAX}$									1
		I <sub>OH</sub> = -4 mA	1.65	1.2			1.2		1.2		
		I <sub>OH</sub> = -8 mA	2.3	1.9			1.9		1.9		1
		I <sub>OH</sub> = -16 mA	3.0	2.4			2.4		2.4		1
		I <sub>OH</sub> = -24 mA	3.0	2.3			2.3		2.3		1
		I <sub>OH</sub> = -32 mA	4.5	3.8			3.8		3.8		
V <sub>OL</sub>	Maximum Low-Level Output	$V_{IN} = V_{T-MIN} \text{ or } V_{T+MAX}$ $I_{OL} = 50 \ \mu A$	1.65 - 5.5			0.1		0.1		0.1	V
	Voltage	$V_{IN} = V_{T-MIN} \text{ or } V_{T+MAX}$									
		I <sub>OL</sub> = 4 mA	1.65			0.45		0.45		0.45	
		I <sub>OL</sub> = 8 mA	2.3			0.3		0.3		0.3	
		I <sub>OL</sub> = 16 mA	3.0			0.4		0.4		0.4	1
		I <sub>OL</sub> = 24 mA	3.0			0.55		0.55		0.55	]
		I <sub>OL</sub> = 32 mA	4.5			0.55		0.55		0.55	
I <sub>IN</sub>	Input Leakage Current	$0 \le V_{IN} \le 5.5 V$	0 to 5.5			±0.1		±1.0		±1.0	μΑ
I <sub>CC</sub>	Quiescent Supply Current	$0 \le V_{IN} \le V_{CC}$	5.5			1.0		10		10	μA

# **AC ELECTRICAL CHARACTERISTICS** (Input $t_r = t_f = 3.0 \text{ ns}$ )

				۲	Γ <sub>A</sub> = 25°0	C	T <sub>A</sub> ≤	+85°C		-55°C 25°C	
Symbol	Parameter	V <sub>CC</sub> (V)	Test Condition	Min	Тур	Мах	Min	Max	Min	Max	Unit
t <sub>PLH</sub> ,	Propagation Delay,	1.65 - 1.95		3.2	8.6	14.4	3.2	14.4	3.2	14.4	ns
t <sub>PHL</sub>	Any Input to Output Y (See Test Circuit)	2.3 - 2.7		2.0	5.1	8.3	2.0	8.3	2.0	8.3	
		3.0 - 3.6		1.5	3.9	6.3	1.5	6.3	1.5	6.3	
		4.5 - 5.5		1.1	3.3	5.1	1.1	5.1	1.1	5.1	
C <sub>IN</sub>	Input Capacitance				3.5						pF
C <sub>PD</sub>	Power Dissipation Capacitance (Note 6)	5.0	f = 10 MHz		22						pF

6.  $C_{PD}$  is defined as the value of the internal equivalent capacitance which is calculated from the dynamic operating current consumption without load. Average operating current can be obtained by the equation  $I_{CC(OPR)} = C_{PD} \bullet V_{CC} \bullet f_{in} + I_{CC}$ .  $C_{PD}$  is used to determine the no-load dynamic power consumption:  $P_D = C_{PD} \bullet V_{CC}^2 \bullet f_{in} + I_{CC} \bullet V_{CC}$ .

# TEST CIRCUIT AND VOLTAGE WAVEFORMS

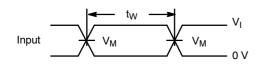


Test	S1
t <sub>PLH</sub> /t <sub>PHL</sub>	Open
t <sub>PLZ</sub> /t <sub>PZL</sub>	V <sub>LOAD</sub>
t <sub>PHZ</sub> /t <sub>PZH</sub>	GND

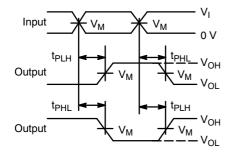
 $*C_L$  includes probes and jig capacitance.

Figure 9. Load Circuit

	Inputs						
V <sub>CC</sub>	VI	t <sub>r</sub> /t <sub>f</sub>	VM	V <sub>LOAD</sub>	C∟	RL	$V_{\Delta}$
$1.8 V \pm 0.15 V$	V <sub>CC</sub>	$\leq 2 \text{ ns}$	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	1 kΩ	0.15 V
$2.5~V~\pm~0.2~V$	V <sub>CC</sub>	$\leq 2 \text{ ns}$	V <sub>CC</sub> /2	$2 \times V_{CC}$	30 pF	500 Ω	0.15 V
$3.3~V~\pm~0.3~V$	3 V	$\leq$ 2.5 ns	1.5 V	6 V	50 pF	500 Ω	0.3 V
$5.5~V~\pm~0.5~V$	V <sub>CC</sub>	$\leq 2.5 \text{ ns}$	V <sub>CC</sub> /2	$2 \times V_{CC}$	50 pF	500 Ω	0.3 V



#### Figure 10. Voltage Waveforms Pulse Duration



#### Figure 12. Voltage Waveforms Propagation Delay Times Inverting and Noninverting Outputs

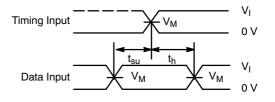
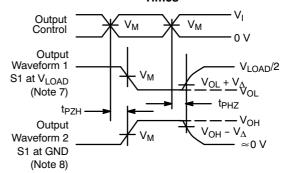


Figure 11. Voltage Waveforms Setup and Hold Times



#### Figure 13. Voltage Waveforms Enable and Disable Times Low- and High-Level Enabling

7. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.

- 8. Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control
- 9. All input pulses are supplied by generators having the following characteristics: PRR  $\leq$  10 MHz, Z<sub>0</sub> = 50  $\Omega$ .

10. The outputs are measured one at a time, with one transition per measurement.

11. All parameters are waveforms are not applicable to all devices.

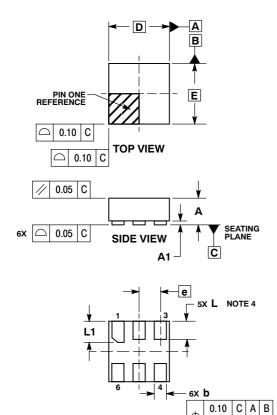
#### **ORDERING INFORMATION**

Device	Package	Shipping <sup>†</sup>
NLX1G97AMX1TCG	ULLGA6 - 0.5P (Pb-Free)	3000 / Tape & Reel
NLX1G97BMX1TCG	ULLGA6 - 0.4P (Pb-Free)	3000 / Tape & Reel
NLX1G97CMX1TCG	ULLGA6 - 0.35P (Pb-Free)	3000 / Tape & Reel

+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

## PACKAGE DIMENSIONS

ULLGA6 1.0x1.0, 0.35P CASE 613AD-01 ISSUE A



**BOTTOM VIEW** 

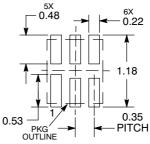
Φ

0.05 C NOTE 3

- NOTES:
  1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
  2. CONTROLLING DIMENSION: MILLIMETERS.
  3. DIMENSION b APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP.
  4. A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED.

PA	PACKAGE IS ALLOWE					
		MILLIMETERS				
D	M	MIN MAX				
4	1		0.40			
A	1	0.00	0.05			
t	)	0.12	0.22			
	)	1.00	BSC			
E		1.00	BSC			
	)	0.35 BSC				
I	_	0.25	0.35			
L	1	0.30	0.40			

**MOUNTING FOOTPRINT** SOLDERMASK DEFINED\*

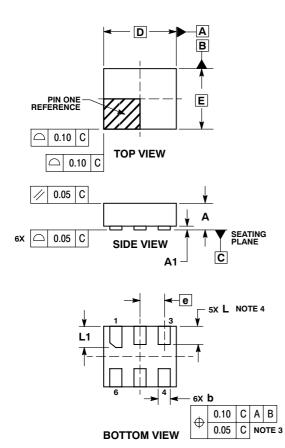


DIMENSIONS: MILLIMETERS

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# PACKAGE DIMENSIONS

ULLGA6 1.2x1.0, 0.4P CASE 613AE-01 ISSUE A

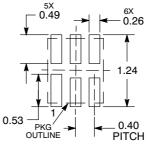


NOTES:

- 1.
- ITES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.13 AND 2. 3.
- AND IS MEASON THE TERMINAL TIP. A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED. 4.

	MILLIMETERS				
DIM	MIN	MAX			
Α		0.40			
A1	0.00	0.05			
b	0.15	0.25			
D	1.20	BSC			
E	1.00	BSC			
е	0.40	BSC			
L	0.25	0.35			
L1	0.35	0.45			

#### **MOUNTING FOOTPRINT** SOLDERMASK DEFINED\*

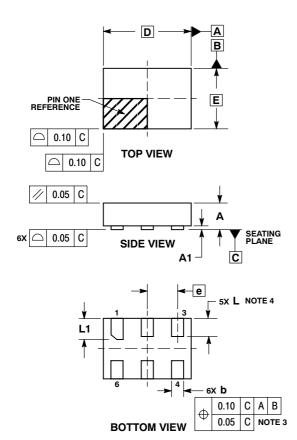


DIMENSIONS: MILLIMETERS

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#### PACKAGE DIMENSIONS

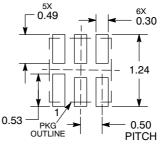
ULLGA6 1.45x1.0, 0.5P CASE 613AF-01 ISSUE A



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. 2
- DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.30 mm FROM THE TERMINAL TIP. 3.
- A MAXIMUM OF 0.05 PULL BACK OF THE PLATED TERMINAL FROM THE EDGE OF THE PACKAGE IS ALLOWED. 4

	MILLIMETERS		
DIM	MIN	MAX	
Α		0.40	
A1	0.00	0.05	
b	0.15	0.25	
D	1.45	BSC	
Е	1.00	BSC	
е	0.50 BSC		
L	0.25	0.35	
L1	0.30	0.40	

**MOUNTING FOOTPRINT** SOLDERMASK DEFINED\*



DIMENSIONS: MILLIMETERS

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